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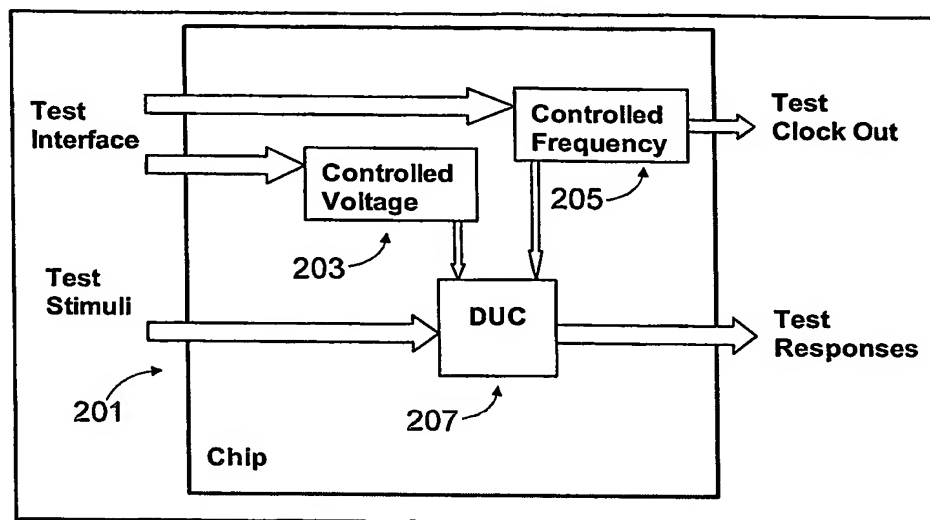
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(54) Title: IC WITH ON-BOARD CHARACTERIZATION UNIT



(57) Abstract: A system and method for providing a built-in characterization of a semiconductor device (201). The device is provided with a built-in, integral, characterization unit (203) which allows characterization of the device without the need for external test equipment.



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